

Monitoring and measuring systems used for data collection, gathering and analysis - Part 1: Device requirements

EESTI STANDARDI EESSÕNA

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English Version

**Monitoring and measuring systems used for data collection,
gathering and analysis - Part 1: Device requirements
(IEC 62974-1:2017)**

Systèmes de surveillance et de mesure utilisés pour la
collecte et l'analyse de données - Partie 1: Exigences
relatives aux dispositifs
(IEC 62974-1:2017)

Erfassungs- und Messsysteme zur Datenerfassung, -
Übertragung und -Analyse - Teil 1: Anforderungen an die
Geräte
(IEC 62974-1:2017)

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Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels

European foreword

The text of document 85/587/FDIS, future edition 1 of IEC 62974-1, prepared by IEC/TC 85 "Measuring equipment for electrical and electromagnetic quantities" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62974-1:2017.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2018-03-26
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2020-06-26

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Endorsement notice

The text of the International Standard IEC 62974-1:2017 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standard indicated :

IEC 60068-1	NOTE	Harmonized as EN 60068-1.
IEC 60068-2-30	NOTE	Harmonized as EN 60068-2-30.
IEC 60364-8-1	NOTE	Harmonized as HD 60364-8-1.
IEC 60950 (Series)	NOTE	Harmonized as EN 60950 (Series).
IEC 61557-12	NOTE	Harmonized as EN 61557-12.
CISPR 24:2010	NOTE	Harmonized as EN 55024:2010.
ISO 50001	NOTE	Harmonized as EN ISO 50001.

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60068-2-1	-	Environmental testing -- Part 2-1: Tests Test A: Cold	-EN 60068-2-1	-
IEC 60068-2-2	-	Environmental testing -- Part 2-2: Tests Test B: Dry heat	-EN 60068-2-2	-
IEC 60068-2-14	-	Environmental testing -- Part 2-14: Tests Test N: Change of temperature	-EN 60068-2-14	-
IEC 60068-2-78	-	Environmental testing -- Part 2-78: Tests Test Cab: Damp heat, steady state	-EN 60068-2-78	-
IEC 60529	-	Degrees of protection provided by- enclosures (IP Code)	-	-
IEC 60721-3-1	-	Classification of environmental conditions - Part 3: Classification of groups of environmental parameters and their severities -- Section 1: Storage	-EN 60721-3-1	-
IEC 60721-3-2	-	Classification of environmental conditions - Part 3: Classification of groups of environmental parameters and their severities -- Section 2: Transportation	-EN 60721-3-2	-
IEC 60721-3-3	-	Classification of environmental conditions - Part 3: Classification of groups of environmental parameters and their severities -- Section 3: Stationary use at weatherprotected locations	-EN 60721-3-3	-
IEC 61000-4-5	-	Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test	EN 61000-4-5	-
IEC 61000-4-8	-	Electromagnetic compatibility (EMC) -- Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test	EN 61000-4-8	-
IEC 61000-4-11	-	Electromagnetic compatibility (EMC) -- Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests	EN 61000-4-11	-
IEC 61010	series	Safety requirements for electrical equipment for measurement, control and laboratory use	EN 61010	series

IEC 61131-2	2003	Programmable controllers -- Part 2:- Equipment requirements and tests	-
IEC 61326-1	-	Electrical equipment for measurement, EN 61326-1 control and laboratory use - EMC requirements -- Part 1: General requirements	-
IEC 62053-31	-	Electricity metering equipment (a.c.) -- EN 62053-31 Particular requirements -- Part 31: Pulse output devices for electromechanical and electronic meters (two wires only)	-
IEC 62262	-	Degrees of protection provided by EN 62262 enclosures for electrical equipment against external mechanical impacts (IK code)	-

CONTENTS

FOREWORD.....	4
INTRODUCTION.....	6
1 Scope.....	7
2 Normative references	7
3 Terms and definitions	8
3.1 General definitions.....	9
3.2 Device definitions	10
3.3 Definitions related to inputs and outputs	10
4 Environmental conditions.....	11
5 Ratings.....	11
6 Design and construction	11
6.1 General.....	11
6.2 Product coding.....	12
6.3 General architecture of devices.....	12
6.4 General data processing	13
6.5 Requirements on minimum functions embedded in devices	13
6.6 Requirements on functions.....	14
6.6.1 General	14
6.6.2 Communication connectivity features.....	14
6.6.3 Management of digital and/or analogue input(s) or output(s).....	15
6.6.4 Data time stamping.....	15
6.6.5 Management of logged data.....	15
6.6.6 Management of aggregated data	16
6.6.7 Analysis of aggregated data	16
6.6.8 Local visualisation on a Human Machine Interface.....	16
6.6.9 Configuration management.....	16
6.7 Safety requirements.....	16
6.7.1 General	16
6.7.2 Clearances and creepage distances	17
6.7.3 Accessible parts	17
6.7.4 Hazardous live parts.....	17
6.8 EMC requirements	17
6.8.1 General	17
6.8.2 Class 1 devices	17
6.8.3 Class 2 devices	17
6.9 Mechanical requirements	17
6.9.1 Product mechanical robustness	17
6.9.2 Enclosure robustness (IK code)	17
6.9.3 Degree of protection by enclosures (IP code)	18
6.10 Marking.....	18
6.10.1 General	18
6.10.2 Device marking.....	18
6.11 Operating and installation instructions	19
6.11.1 General	19
6.11.2 Pulse input(s)/output(s)	19
6.11.3 Installation description.....	19

7	Type tests	20
7.1	Performance criteria for type tests	20
7.2	Safety tests	21
7.3	EMC tests	21
7.4	Climatic tests	21
7.5	Mechanical tests	22
7.5.1	Degree of protection provide by enclosures for electrical equipment against external mechanical impacts (IK code)	22
7.5.2	Degree of protection by enclosure (IP code)	22
8	Routine tests	22
	Annex A (informative) Example of system architectures	23
	Annex B (informative) Example of device processing	25
	Bibliography	26
	Figure 1 – Lifecycle solutions for energy efficiency	6
	Figure 2 – General architecture of devices	13
	Figure A.1 – Basic local monitoring and measuring system architecture	23
	Figure A.2 – Advanced local monitoring and measuring system architecture	23
	Figure A.3 – Remote monitoring and measuring system architecture	24
	Figure B.1 – General data processing of the general device	25
	Table 1 – Environmental conditions	11
	Table 2 – Devices coding table	12
	Table 3 – List of minimum functions of the devices	14
	Table 4 – Enclosure mechanical requirements	18
	Table 5 – Minimum IP requirements	18
	Table 6 – Marking to apply to devices	19
	Table 7 – Specific performance criteria	20
	Table 8 – Additional tests for class 2 devices	21
	Table 9 – Climatic requirements	22

INTRODUCTION

The use of electrical energy needs to be optimised worldwide to ensure more efficient use of available energy sources, for enhanced competitiveness, and for reducing greenhouse gas emissions and other related environmental impacts.

It implies better energy management leading to a necessary improvement of energy performance, particularly in terms of efficiency, use and consumption. This can be summarized by the lifecycle shown in Figure 1:

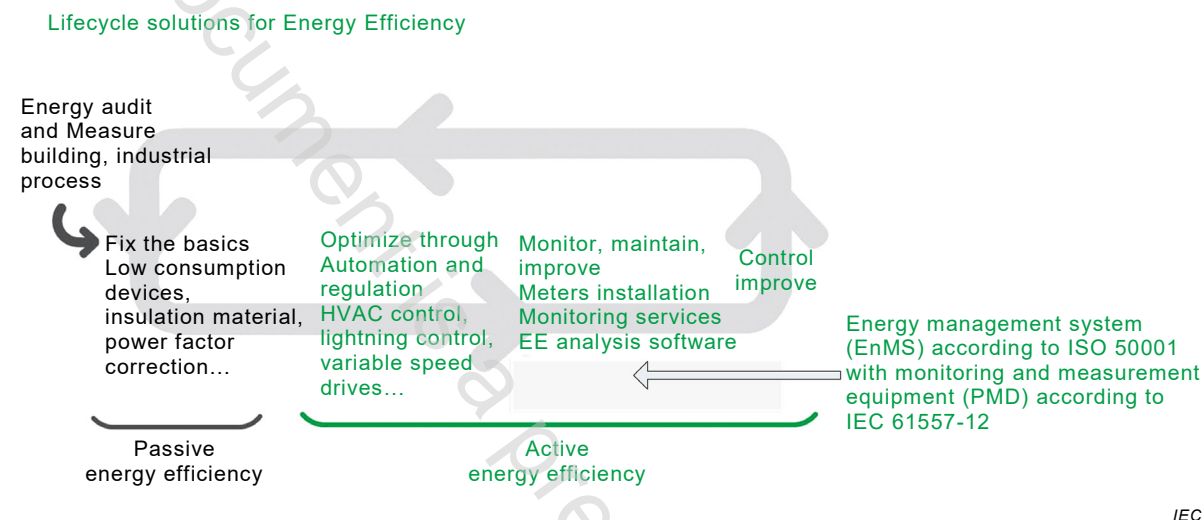


Figure 1 – Lifecycle solutions for energy efficiency

Standards such as ISO 50001, ISO 50002, ISO 50006 and IEC 60364-8-1 are providing information related to this topic.

What is not known cannot be changed, and what is not measured is not known. Consequently, there is an increasing need to measure energy within the installations in order to:

- monitor performance indicators or to monitor energy baselines, or
- compare energy performance between baseline period and reporting period as described in ISO 50006.

Measurements can be collected by employees at a defined frequency, provided absences are accounted for (vacation, off sick, etc.), provided the measurements are relevant (number of measurement points to collect) and provided measurements can be relatively coherent (synchronism).

This is why more and more devices are used for collection, gathering and sometimes analysis of measured data. Some typical architectures are given in Annex A.